

Transmissive Final Optic for Laser IFE



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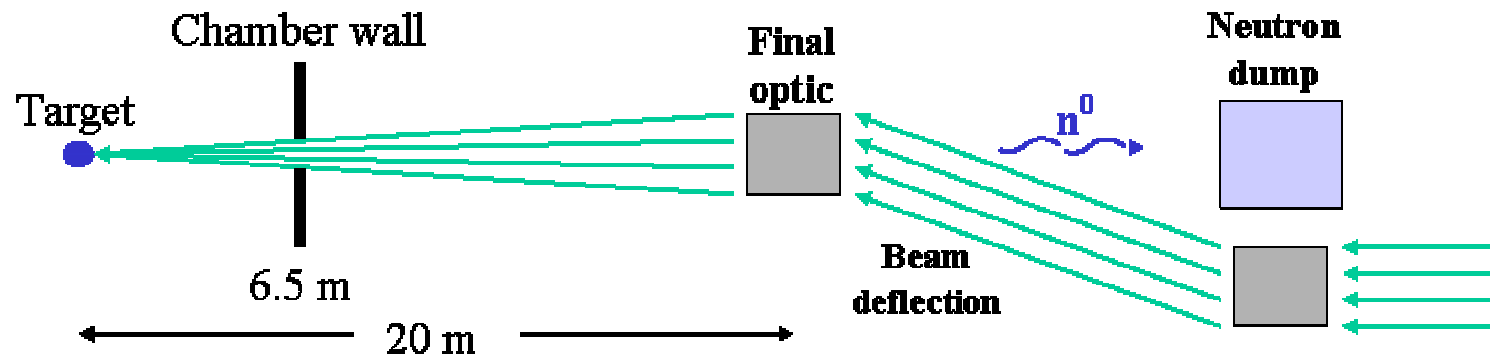
General Atomics, San Diego, California

We have completed our study of the fused silica final optic (FO) option for 0.35 μm light, based on a “thin” Fresnel lens



Goal is to define the “operating window” for thin SiO_2 FO solution:

- Comparison of SiO_2 with other robust optical materials
- Effect of neutrons and gammas on optical properties
- Thermal management of laser heating with radiative cooling
- Accommodation of focusing, beam deflection, and smoothing



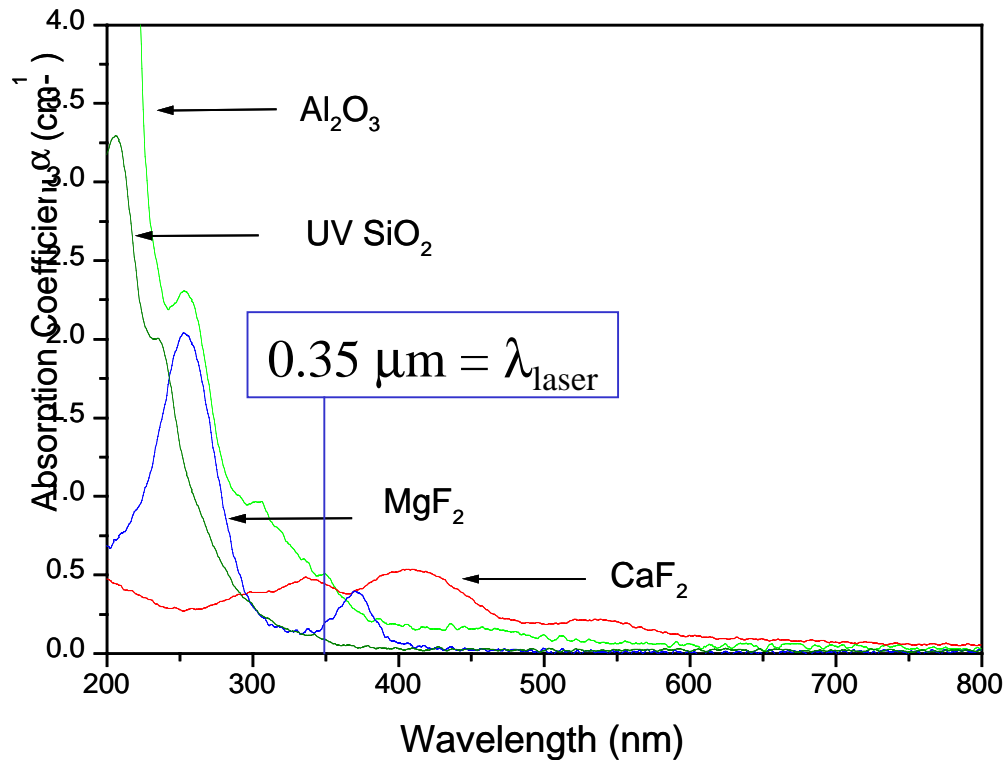
Several additional issues may need to be addressed:

- Transient response to neutrons (LANL)
- X-ray ablation of the surface
- Ion sputtering of the surface
- Shrapnel from the target

We have directly compared the absorption at 0.35 μm produced by 1 Mrad of neutrons for SiO_2 , MgF_2 , CaF_2 and Al_2O_3 (ACRR, Sandia)



1 Mrad dose on ACRR



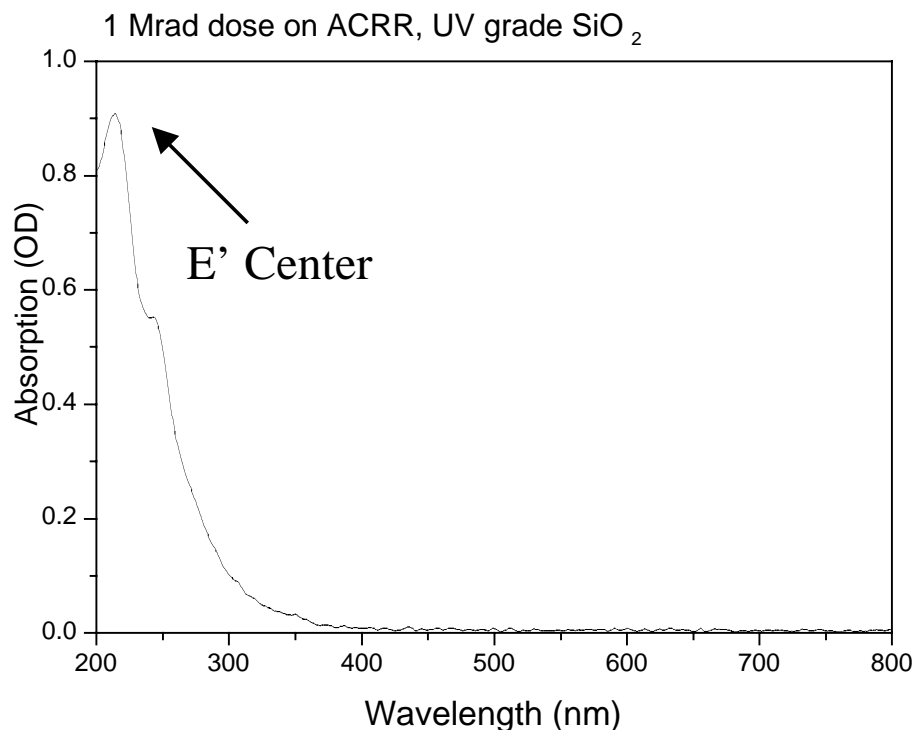
Optical Material	Absorption at 0.35 μm , $\alpha(\text{cm}^{-1})$
SiO_2	0.03
Al_2O_3	0.45
MgF_2	0.15
CaF_2	0.45

- SiO_2 yields *least absorption* at 0.35 μm for given neutron dose

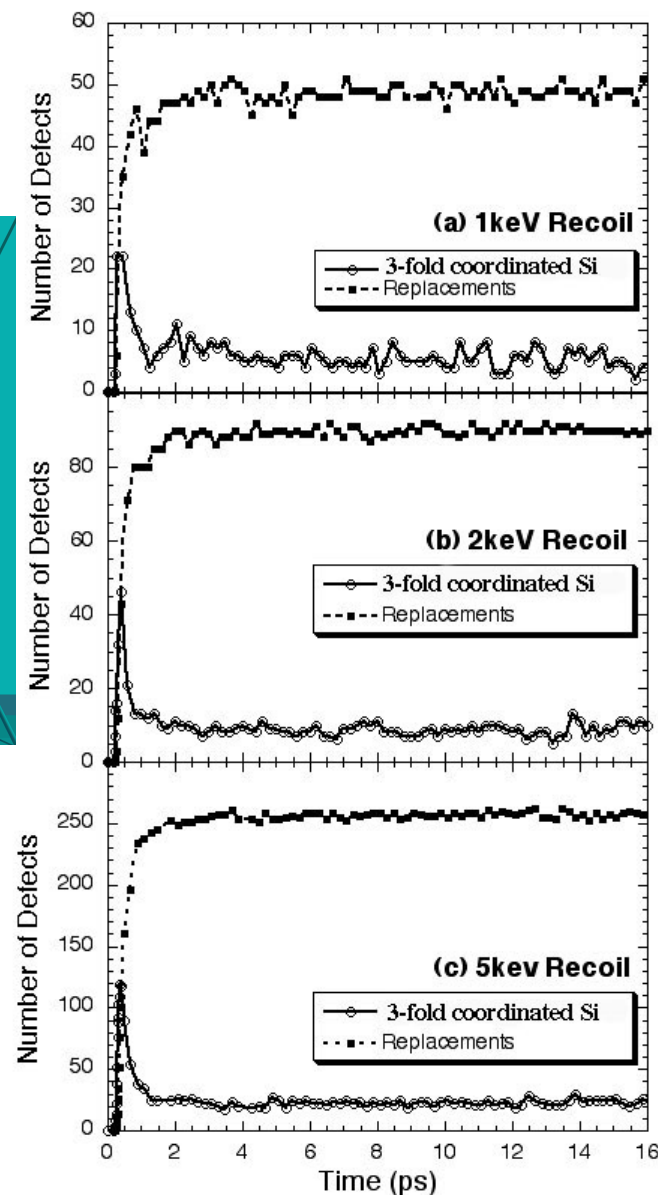
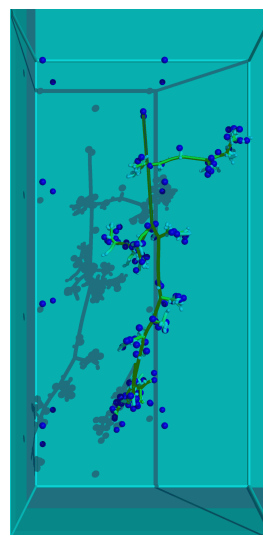
Neutron-induced defect formation has been studied by Molecular Dynamics Simulations (MDS) and absorption spectroscopy



Absorption spectrum (1 Mrad)

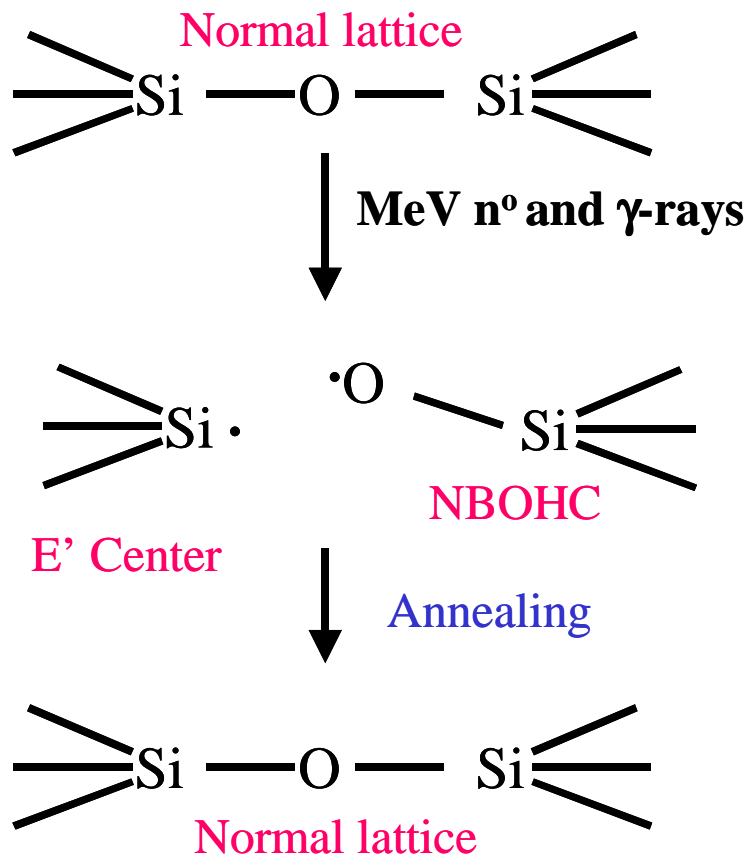


MDS



- Experimentally, 35 defects are created per 1 MeV neutron collision
- Based on MDS, ~ 400 are predicted
- Difference due to “slow” (>psec) recombination

Simple mechanism of defect creation and annealing is supported by several observations

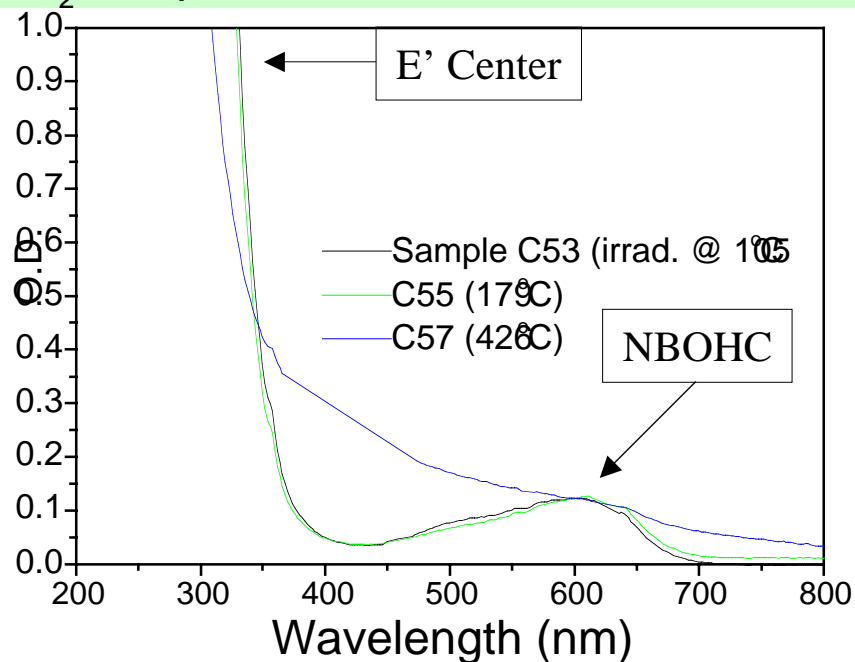


- Spectra of E' and Non-Bridging Oxygen Holes Centers (NBOHCs) observed
- E' centers and NBOHCs are formed in nearly equal number
- *Complete* elimination of defects by thermal annealing is possible
- Model is consistent with Molecular Dynamics Simulations

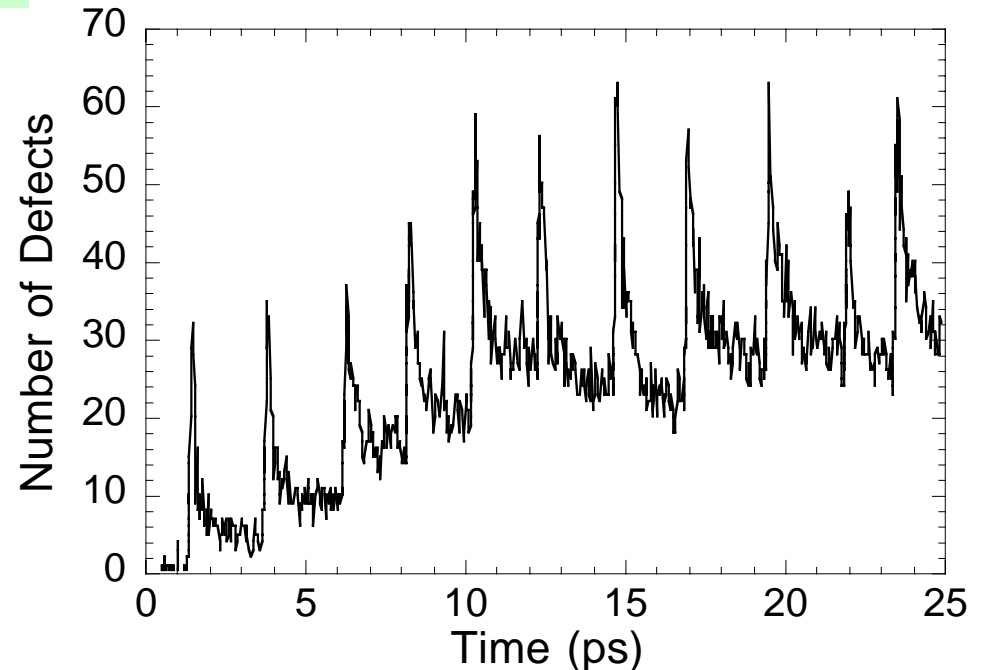
We have observed “radiation-annealing” in an optical material for the first time



SiO₂ samples irradiated at LANSCE for 1¹¹ rad



Multiple recoils in same location (MDS)

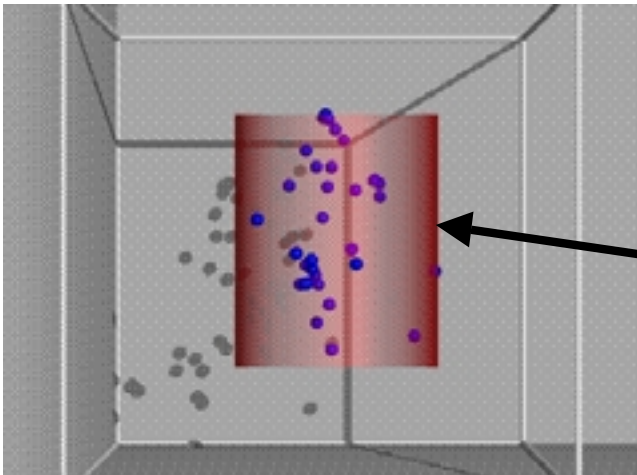
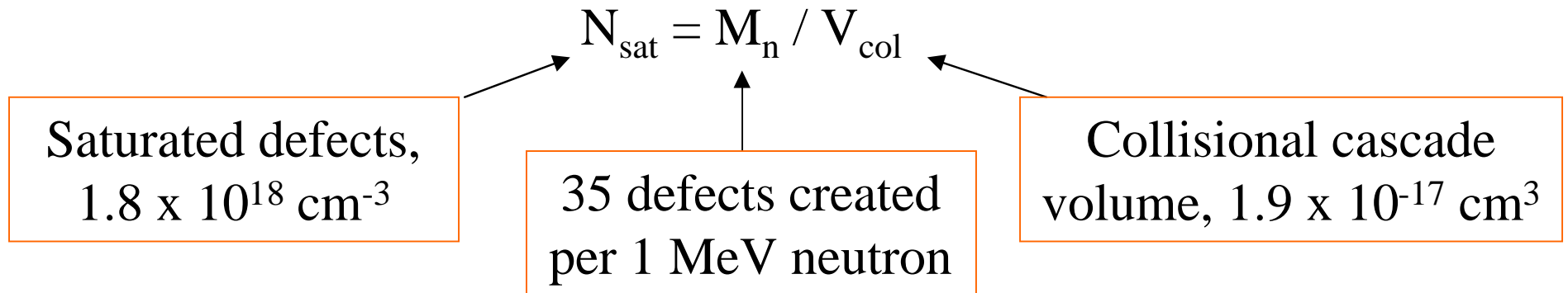


- “Low dose” (1 Mrad) results, on prior vugraph, indicate 35 defects are formed per 1 MeV neutron collision
- “High dose” (10⁵ Mrad) results, above, suggest 0.007 defects / collision
- Hypothesis is that overlapping collisional cascades give rise to “**radiation annealing**”
- Molecular Dynamics Simulations (MDS), above, reveal defects saturate after 5 cascades

As test of our radiation-annealing theory, measured and calculated collisional cascade volumes are compared



“Measured” volume of collisional cascade:

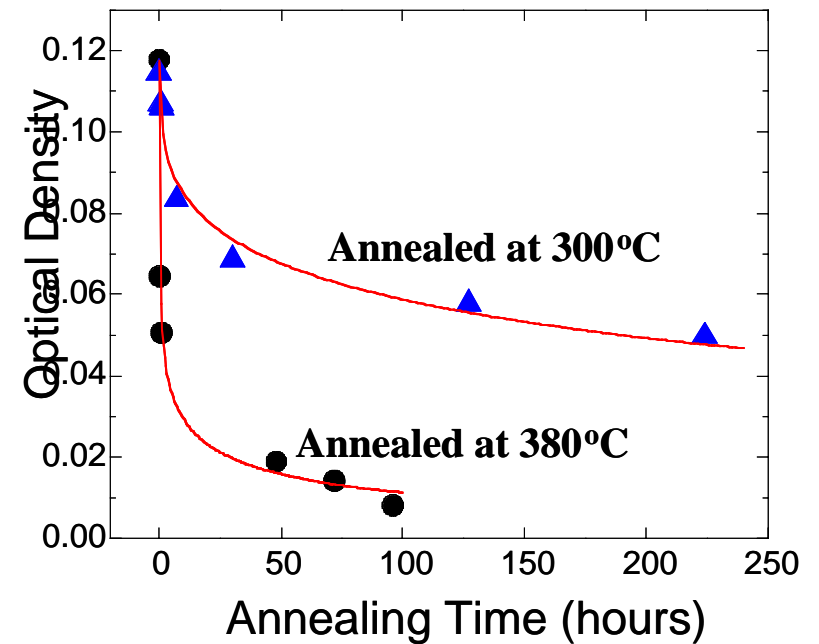
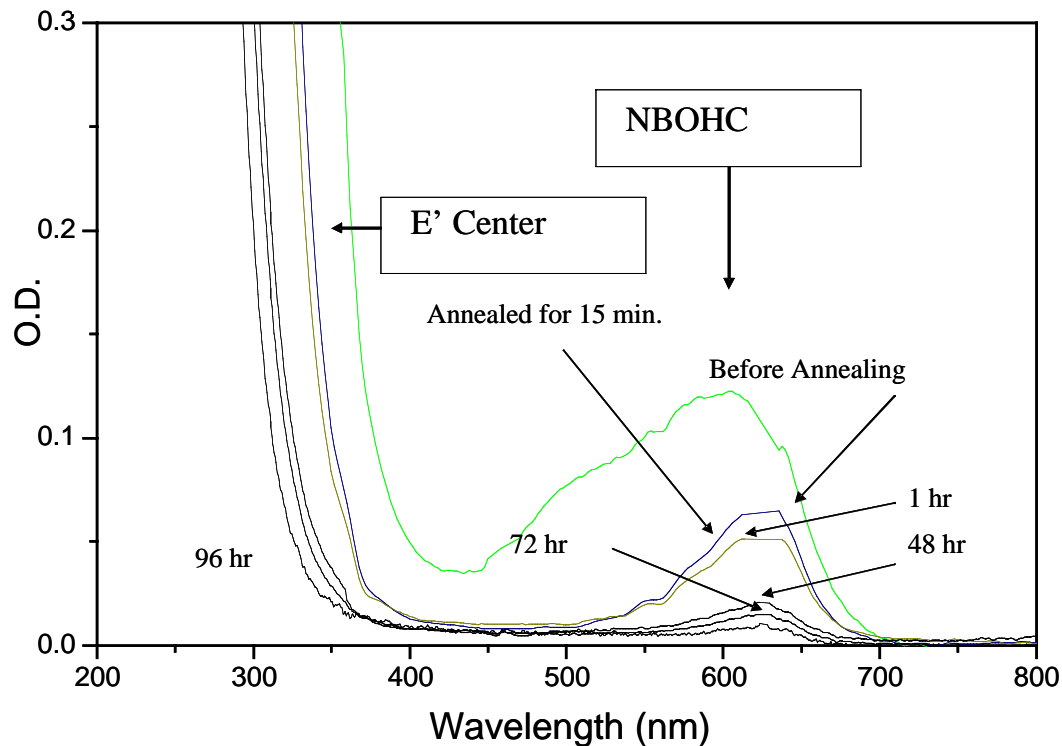


- Measured: $V_{\text{col}} = 200 \text{ nm}^3$ per 1 keV recoil
- Theory: 200 nm^3 “box” is compared with distribution of defects from MDS

Annealing of defects has been quantified at two temperatures



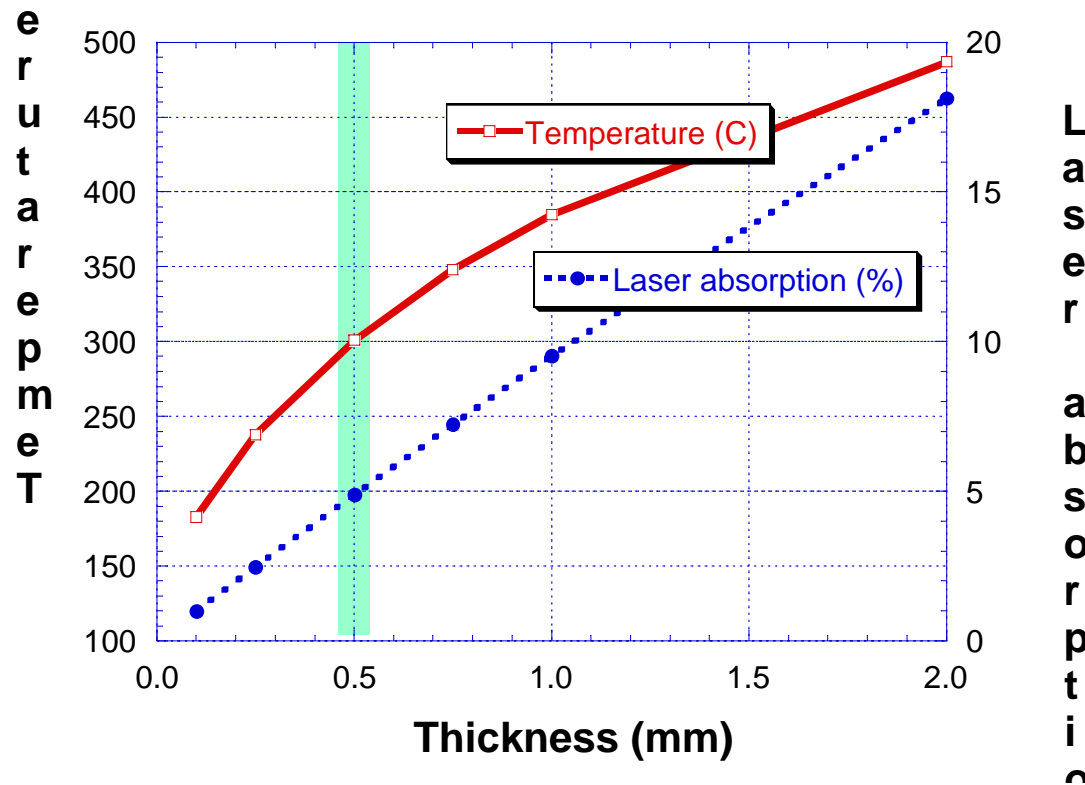
Reduction in absorption from annealing at 380 °C



Fit to: $\tau_{\text{anneal}} = \tau_0 \exp (+ T_{\text{anneal}} / T)$

• $T_{\text{anneal}} = 21,000 \text{ } ^\circ\text{K}$ and $\tau_0 = 4 \times 10^{-10} \text{ sec}$

Final optic must be < 0.5 mm thickness to avert excessive losses or temperature rise



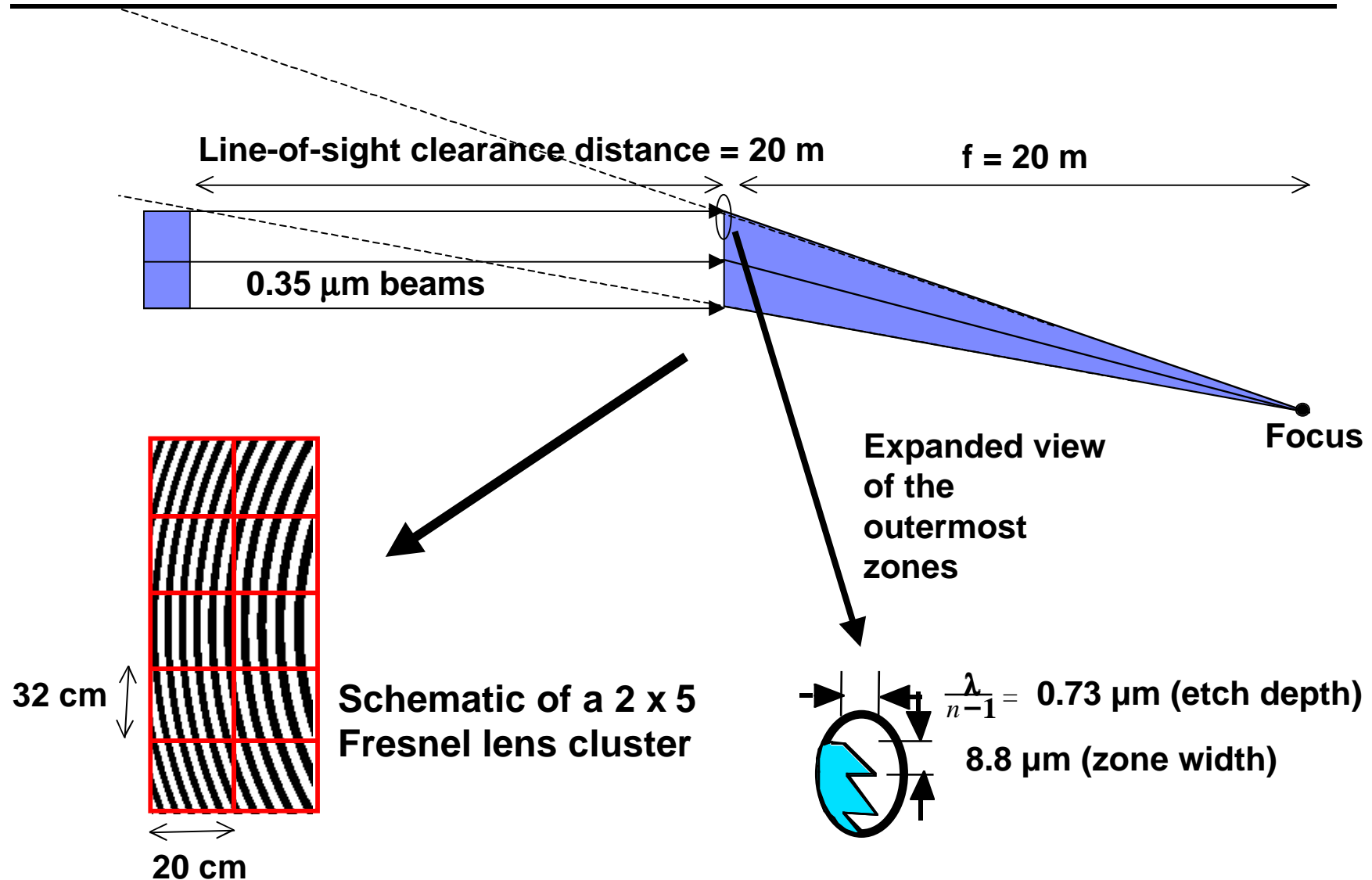
Based on radiative cooling with 0.5 mm thickness:

- $T = 300^{\circ}\text{C}$
- $f_{\text{abs}} = 5\%$ absorption

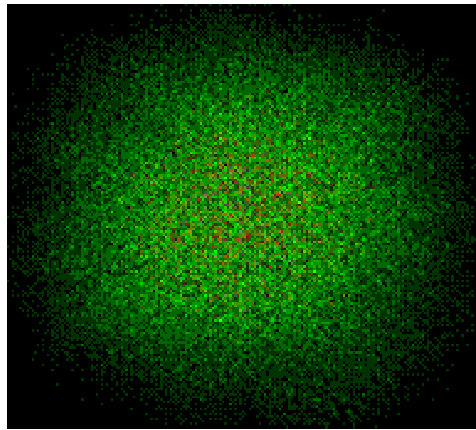
Cooling from one-side only (most conservative) has no effect on focus (second order effect – Ω_{bend}^2):

$$\Omega_{\text{bend}} = \alpha_{\text{exp}} f_{\text{abs}} F_{\text{laser}} v_{\text{rep}} d_{\text{optic}} / 2 \kappa = 0.5 \text{ mrad}$$

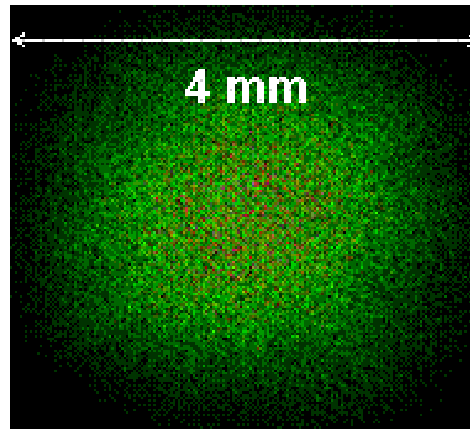
Final optic design is off-axis Fresnel lens for focusing and deflection



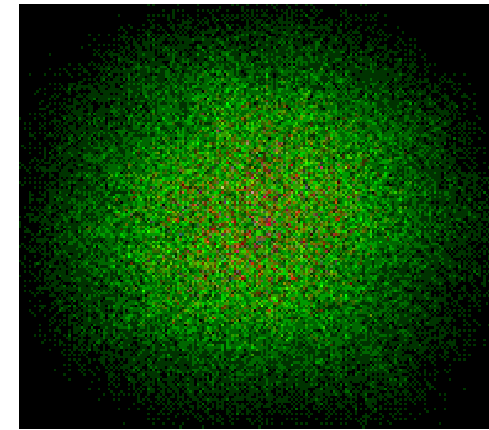
Combination of Fresnel lens and phase plate to yield spot size of ~3 mm for direct drive target



**15 mm before
focus**



At focus



15 mm after focus

- Calculation includes effects of 1 THz bandwidth
- Calculated transmission efficiency is 99 % for linear grooves

Description of neutron-induced defects for SiO₂ under IFE conditions



Temperature of optic, $T_{\text{SiO}_2} = 300 \text{ }^\circ\text{C}$:

- $Q_{\text{heat}} = \alpha_{\text{abs}} d_{\text{SiO}_2} F_{\text{laser}} v_{\text{rep}} + F_{\text{view}} \sigma [T_{\text{cham}}^4 - T_{\text{SiO}_2}^4]$
- $Q_{\text{cool}} = \varepsilon \sigma [T_{\text{SiO}_2}^4 - T_{\text{surr}}^4]$

Annealing time, $\tau_{\text{anneal}} = 916 \text{ hrs}$:

- $\tau_{\text{anneal}} = \tau_0 d_{\text{SiO}_2} \exp[T_{\text{anneal}} / T_{\text{SiO}_2}]$

Defect Concentration, $N_{\text{defect}} = 1.8 \times 10^{18} \text{ cm}^{-3}$:

- $dN_{\text{E}'} / dt = M_n (\sigma_n N_{\text{SiO}_2}) \phi_n [(N_{\text{sat}} - N_{\text{E}'}) / N_{\text{sat}}] - N_{\text{E}'} / \tau_{\text{anneal}}$

Laser absorption, $f_{\text{abs}}(0.35\mu\text{m}) = 5\%$

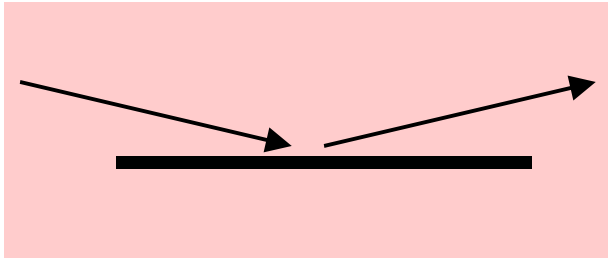
- Thinner optic would be advantageous

Summary of IFE deployment issues for off-axis Fresnel lens



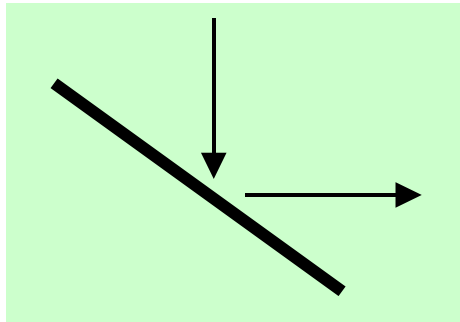
Issue	Amelioration
Absorption of 10%/mm	Thickness of <0.5 mm
Scatter loss of 0.6 %/mm	
Heating of optic	
Fabrication	1 mm easy, 0.5 mm achievable, 0.25 mm possible
Density increase (saturates at 2.6 %)	Pre-treat optics to radiation
Avoiding optical damage	Laser fluence of $\sim 1.5 \text{ J/cm}^2$
Optical bandwidth (1 THz)	Minor effect on focus
Misalignment / bending	

Aluminum mirrors, dielectric mirrors, and transmissive optics are all candidates for the IFE final optic



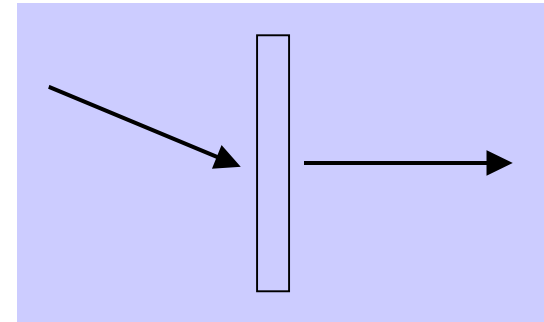
Aluminum mirror

- <10 nm evanescent wave
- grazing incidence
- 3ω and 4ω



Dielectric mirror

- $\sim 10 \mu\text{m}$ “optical depth”
- arbitrary reflection angle
- 3ω and 4ω



Transmissive optic

- ~ 0.5 mm path length
- few degree deflection
- 3ω only

Radiation hardness studies of dielectric mirrors are planned

- Common constituents are SiO_2 , ZrO_2 , HfO_2 , Ta_2O_5 , MgF_2
- HfO_2 , Ta_2O_5 are neutron absorbers, and become highly radioactive
- High damage threshold SiO_2 - ZrO_2 mirrors planned for irradiations
 - predict 0.2 rem / hr after 100 Mrad dose on HFER at ORNL